

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/660,636	ISHII ET AL.	
			Examiner	Art Unit	Page 1 of 1
			Sophia S. Chen	2852	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,323,306	04-1982	Ito et al.	399/358
	B	US-5,065,195	11-1991	Haneda et al.	399/358(X)
	C	US-5,121,168	06-1992	Aoki et al.	399/359
	D	US-5,146,270	09-1992	Matsuo et al.	399/358(X)
	E	US-5,537,191	07-1996	Aruga et al.	399/359(X)
	F	US-5,617,195	04-1997	Torimaru et al.	399/358(X)
	G	US-6,085,052	07-2000	Yamane et al.	399/358(X)
	H	US-6,493,528 B2	12-2002	Sameshima et al.	399/360(X)
	I	US-2003/0219290 A1	11-2003	Harumoto et al.	399/358
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	08-328366	12-1996	Japan	Tokimatsu et al.	-----/-----
	O	11-003015	01-1999	Japan	Kimura et al.	-----/-----
	P	2001-296712	10-2001	Japan	Shimotoso et al.	-----/-----
	Q	2002-006574	01-2002	Japan	Shimotoso et al.	-----/-----
	R	2002-148884	05-2002	Japan	Honobe et al.	-----/-----
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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